

Substitute for form 1449A/PTO (modified)		Application Number	10/762678
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <small>O I P E J C O</small> <small>NOV 29 2004</small> <small>as many sheets as necessary)</small> <small>Page 1 of 4</small>		Filing Date	January 20, 2004
		First Named Inventor	Onderkirk, Andrew J.
		Art Unit	2882
		Examiner Name	Andrew E Keaney
		Attorney Case Number	59418US002

U.S. Patent Documents					
Exam. Init.*	Cite No.	Document Number Doc. Number-(Kind Code if Known)	Publication Date or Issue Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
EMK	A1	US- 2001-001207	5/17/01	Shimizu et al.	
EMK	A2	US- 2001-0013668	8/16/01	Neavin et al.	
EMK	A3	US- 2002-0017651	2/14/02	Kato et al.	
EMK	A4	US- 2002-0043926	4/18/02	Takahashi et al.	
EMK	A5	US- 2002-0054406	5/09/02	Duerksen	
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EMK	A28	US- 5,540,978	7/30/96	Schrenk	

*Examiner: Andrew E Keaney Date Considered: 8/30/05

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Application Number	10/762678
Filing Date	January 20, 2004
First Named Inventor	Ouderkirk, Andrew J.
Art Unit	2882
Examiner Name	Unknown G Kealey
Attorney Case Number	59418US002

U.S. Patent Documents

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		Doc. Number-(Kind Code if Known)			
BNK	A29	US- 5,540,987	7/30/96	Mudge et al.	
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*Examiner: Elegan G Kealey Date Considered: 8/30/05

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First Named Inventor	Ouderkirk, Andrew J.
Art Unit	2882
Examiner Name	E. Kealey
Attorney Case Number	59418US002

U.S. Patent Documents

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		Doc. Number-(Kind Code if Known)			
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EMK	B7	WO	97/10278 English Abstract	3/20/97			
EMK	B8	WO	WO 97/48138	12/18/97			
EMK	B9	WO	WO 99/36248	7/22/99			
EMK	B10	WO	WO 99/60303	11/25/99			
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EMK	B16	JP	JP 11274572 English Abstract	10/08/99			
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OTHER DOCUMENTS

Exam. Init.*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation (Check if yes)
EMK	C1	US Application No. 60/407,426, Soules et al., "Coated LED With Improved Efficiency," filed August 30, 2002.	

*Examiner: *Elizabeth Kealey*Date Considered: *8/30/05*

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Application Number

10/762678

Filing Date

January 20, 2004

First Named Inventor

Onderkirk, Andrew J.

Art Unit

1631 2882

Examiner Name

Kulbawow E. Keane

Attorney Case Number

59418US002

OTHER DOCUMENTS

Exam. Init.*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation (Check if yes)
EMK	C2	US Application No. 10/726244; Simbal, John J.; "Reflective Light Coupler"; filed 12/2/2003.	
EMK	C3	US Application No. 10/727220; Schultz, John C.; "Illumination Assembly"; filed 12/2/2003.	
EMK	C4	US Application No. 10/726225; Henson, Gordon D.; "Solid State Light Device"; filed 12/2/2003.	
EMK	C5	US Application No. 10/726248; Watson, James E.; "Multiple LED Source and Method for Assembling Same"; filed 12/2/2003.	
EMK	C6	US Application No. 10/739792; Onderkirk, Andrew J.; "Display Including a Solid State Light Device and Method Using Same"; filed 12/18/2003.	
EMK	C7	US Application No. 10/726257; Aguirre, Francis M.; "LED Curing Apparatus and Method"; filed 12/2/2003.	
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*Examiner: *Christopher Keane*Date Considered: *8/30/05*

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Substitute for form 1449A/PTO (modified)		Application Number	10/726968
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		Filing Date	December 2, 2003
AUG 12 2005 (Use as many sheets as necessary)		First Named Inventor	Ouderkirk, Andrew J.
Page 1 of 1		Art Unit	2882
		Examiner Name	Keaney, Elizabeth Marie
		Attorney Case Number	59418US002

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EMK	A1	US- 6,652,996	11/25/2003	Steklenski et al.	
EMK	A2	US- 6,717,348	04/06/2004	Takahashi	

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DW	C1	Inquiry Documents, 54 pages.				

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DW	C1	Inquiry Documents, 54 pages.			

*Examiner: <u>Elizabeth Keaney</u>	Date Considered: <u>8/31/05</u>
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